FIXED DIP DELAY LINE $T_D/T_R = 5$ (SERIES 1504)



FEATURES PACKAGE

• Fast rise time for high frequency applications

- Delays as large as 1000ns available
- Low DC resistance
- Standard 16-pin DIP package
- Epoxy encapsulated
- Meets or exceeds MIL-D-23859C

IN	1	∪ 16	Ь	N/C
N/C	2	15		N/C
N/C	3	14	Þ	N/C
N/C	4	13	\vdash	N/C
OUT	5	12		N/C
N/C	6	11		N/C
N/C	7	10		N/C
GND	8	9		N/C

1504-xxz $xx = Delay(T_D)$

z = Impedance Code

FUNCTIONAL DESCRIPTION

The 1504-series device is a fixed, single-input, single-output, passive delay line. The signal input (IN) is reproduced at the output (OUT), shifted by a time (T_D) given by the device dash number. The characteristic impedance of the line is given by the letter code that follows the dash number (See

IN Signal Input
OUT Signal Output
GND Ground

PIN DESCRIPTIONS

Table). The rise time (T_R) of the line is 20% of T_D , and the 3dB bandwidth is given by 1.75 / T_D .

SERIES SPECIFICATIONS

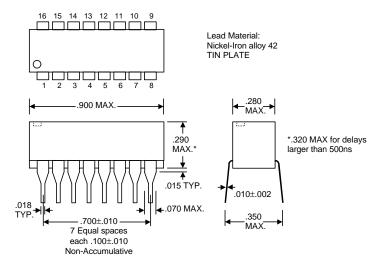
Dielectric breakdown: 50 Vdc
 Distortion @ output: 10% max.
 Operating temperature: -55°C to +125°C

Storage temperature: -55°C to +125°C
 Temperature coefficient: 100 PPM/°C
 Functional Diagram

DASH NUMBER SPECIFICATIONS

Part	Delay	Imped	RDC	Part	Delay	Imped	RDC	Part	Delay	Imped	RDC
Number	(ns)	(Ω)	(Ω)	Number	(ns)	(Ω)	(Ω)	Number	(ns)	(Ω)	(Ω)
1504-20A	20 ± 1.0	50	1.0	1504-160C	160 ± 8.0	200	7.0	1504-40F	40 ± 2.0	400	8.5
1504-25A	25 ± 1.3	50	1.0	1504-180C	180 ± 9.0	200	8.5	1504-80F	80 ± 4.0	400	9.0
1504-30A	30 ± 1.5	50	1.2	1504-240C	240 ± 12.0	200	9.5	1504-120F	120 ± 6.0	400	9.0
1504-40A	40 ± 2.0	50	1.5	1504-300C	300 ± 15.0	200	16.0	1504-160F	160 ± 8.0	400	16.0
1504-45A	45 ± 2.3	50	1.5	1504-400C	400 ± 20.0	200	18.0	1504-200F	200 ± 10.0	400	18.0
1504-60A	60 ± 3.0	50	1.5	1504-25D	25 ± 1.3	250	5.0	1504-240F	240 ± 12.0	400	20.0
1504-75A	75 ± 3.8	50	1.8	1504-50D	50 ± 2.5	250	5.5	1504-320F	320 ± 16.0	400	26.0
1504-100A	100 ± 5.0	50	2.0	1504-75D	75 ± 3.8	250	6.0	1504-360F	360 ± 18.0	400	28.0
1504-10B	10 ± 1.0	100	1.0	1504-100D	100 ± 5.0	250	7.0	1504-480F	480 ± 24.0	400	38.0
1504-20B	20 ± 1.0	100	1.5	1504-125D	125 ± 6.3	250	8.0	1504-600F	600 ± 30.0	400	45.0
1504-30B	30 ± 1.5	100	1.5	1504-150D	150 ± 7.5	250	8.5	1504-800F	800 ± 40.0	400	40.0
1504-40B	40 ± 2.0	100	1.8	1504-200D	200 ± 10.0	250	10.0	1504-50G	50 ± 2.5	500	6.0
1504-50B	50 ± 2.5	100	2.0	1504-225D	225 ± 12.0	250	11.0	1504-100G	100 ± 5.0	500	10.0
1504-60B	60 ± 3.0	100	3.0	1504-300D	300 ± 15.0	250	17.0	1504-150G	150 ± 7.5	500	16.0
1504-80B	80 ± 4.0	100	3.5	1504-375D	375 ± 18.8	250	20.0	1504-200G	200 ± 10.0	500	30.0
1504-100B	100 ± 5.0	100	4.0	1504-500D	500 ± 25.0	250	24.0	1504-220G	220 ± 11.0	500	31.0
1504-120B	120 ± 6.0	100	4.0	1504-30E	30 ± 1.5	300	5.0	1504-250G	250 ± 12.5	500	25.0
1504-150B	150 ± 7.5	100	5.0	1504-60E	60 ± 3.0	300	6.0	1504-300G	300 ± 15.0	500	26.0
1504-200B	200 ± 10.0	100	6.0	1504-90E	90 ± 4.5	300	7.0	1504-380G	380 ± 19.0	500	33.0
1504-250B	250 ± 12.5	100	7.0	1504-120E	120 ± 6.0	300	8.0	1504-400G	400 ± 20.0	500	42.0
1504-20C	20 ± 1.0	200	3.0	1504-150E	150 ± 7.5	300	9.0	1504-450G	450 ± 22.5	500	45.0
1504-40C	40 ± 2.0	200	4.0	1504-180E	180 ± 9.0	300	11.0	1504-500G	500 ± 25.0	500	55.0
1504-60C	60 ± 3.0	200	4.5	1504-240E	240 ± 12.0	300	16.0	1504-600G	600 ± 30.0	500	58.0
1504-80C	80 ± 4.0	200	5.5	1504-270E	270 ± 13.5	300	18.0	1504-750G	750 ± 37.5	500	50.0
1504-100C	100 ± 5.0	200	6.0	1504-360E	360 ± 18.0	300	21.0	1504-1000G	1000 ± 50	500	65.0
1504-120C	120 ± 6.0	200	6.5	1504-450E	450 ± 22.5	300	24.0				
1504-140C	140 ± 7.0	200	7.0	1504-600E	600 ± 30.0	300	40.0				

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Package Dimensions

PASSIVE DELAY LINE TEST SPECIFICATIONS

TEST CONDITIONS

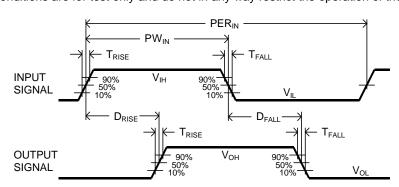
INPUT: OUTPUT:

Source Impedance: 50Ω Max.

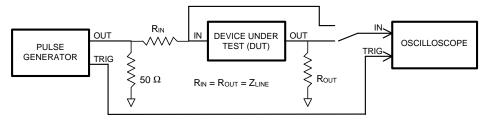
Rise/Fall Time: 3.0 ns Max. (measured

at 10% and 90% levels)

NOTE: The above conditions are for test only and do not in any way restrict the operation of the device.



Timing Diagram For Testing



Test Setup